

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit	Dawn Garrett	
		1774	Page 1 of 1	

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	B	US-5,281,489	01-1994	Mori et al.	428/690
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	X	Adachi et al., Appl. Phys. Lett., 56 (9), 26 February 1990, p. 799-801.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.